Application/Control No. Applicant(s)/Patent Under Reexamination 10/790,394 TANAKA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Alvin C. Chin-Shue 3634 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-3,872,895 Α 03-1975 Takada, Takezo 139/383R US-В US-С US-D US-Ε F US-G US-US-Н US-١ US-J US-Κ US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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